

**Search Notes**

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Examiner

Tam Nguyen

Applicant(s)/Patent under  
Reexamination

RECK ET AL.

Art Unit

3764

**SEARCHED**

Class	Subclass	Date	Examiner
482	1,3- 9,51,56,57 63-65	7/7/2006	TN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR